Search Notes			
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## ###	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/780,512	HUANG ET AL.
	Examiner	Art Unit
	Chris C. Chu	2815

	SEAR	CHED	:
Class	Subclass	Date	Examiner
257	620, 758, 483 and 484	3/24/2005	C.C.

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Searched in US-PGPUB; USPAT; USOCR; EPO; DERWENT; JPO; and IBM_TDB;	3/24/2005	C.C.